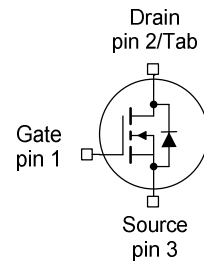


**OptiMOS<sup>®</sup> -T2 Power-Transistor**


- N-channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- Green product (RoHS compliant)
- 100% Avalanche tested

**Product Summary**

$V_{DS}$	30	V
$R_{DS(on),max}$	5.5	mΩ
$I_D$	50	A

**PG-TO252-3-11**


Type	Package	Marking
IPD50N03S4L-06	PG-TO252-3-11	4N03L06

**Maximum ratings, at  $T_j=25\text{ °C}$ , unless otherwise specified**

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current <sup>1)</sup>	$I_D$	$T_C=25\text{ °C}, V_{GS}=10\text{V}$	50	A
		$T_C=100\text{ °C}, V_{GS}=10\text{V}^{2)}$	50	
Pulsed drain current <sup>2)</sup>	$I_{D,pulse}$	$T_C=25\text{ °C}$	200	
Avalanche energy, single pulse <sup>2)</sup>	$E_{AS}$	$I_D=50\text{A}$	36	mJ
Avalanche current, single pulse	$I_{AS}$	-	50	A
Gate source voltage	$V_{GS}$	-	±16	V
Power dissipation	$P_{tot}$	$T_C=25\text{ °C}$	56	W
Operating and storage temperature	$T_j, T_{stg}$	-	-55 ... +175	°C
IEC climatic category; DIN IEC 68-1	-	-	55/175/56	-

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Thermal resistance, junction - case	$R_{thJC}$	-	-	-	2.7	K/W
SMD version, device on PCB	$R_{thJA}$	minimal footprint	-	-	62	
		6 cm <sup>2</sup> cooling area <sup>3)</sup>	-	-	40	

**Electrical characteristics**, at  $T_j=25^\circ\text{C}$ , unless otherwise specified

#### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=1\text{mA}$	30	-	-	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=20\mu\text{A}$	1.0	1.5	2.2	
Zero gate voltage drain current	$I_{DSS}$	$V_{DS}=30V, V_{GS}=0V, T_j=25^\circ\text{C}$	-	0.1	1	$\mu\text{A}$
		$V_{DS}=30V, V_{GS}=0V, T_j=125^\circ\text{C}^{2)}$	-	10	100	
Gate-source leakage current	$I_{GSS}$	$V_{GS}=16V, V_{DS}=0V$	-	-	100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=4.5V, I_D=25\text{A}$	-	6.9	9.0	m $\Omega$
		$V_{GS}=10V, I_D=50\text{A}$	-	4.9	5.5	

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Input capacitance	$C_{iss}$	$V_{GS}=0V, V_{DS}=25V,$ $f=1MHz$	-	1790	2330	pF
Output capacitance	$C_{oss}$		-	460	600	
Reverse transfer capacitance	$C_{rss}$		-	17	34	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=15V, V_{GS}=10V,$ $I_D=30A, R_G=1.6\Omega$	-	3	-	ns
Rise time	$t_r$		-	1	-	
Turn-off delay time	$t_{d(off)}$		-	19	-	
Fall time	$t_f$		-	7	-	

### Gate Charge Characteristics<sup>2)</sup>

Gate to source charge	$Q_{gs}$	$V_{DD}=24V, I_D=50A,$ $V_{GS}=0 \text{ to } 10V$	-	6	8	nC
Gate to drain charge	$Q_{gd}$		-	3	6	
Gate charge total	$Q_g$		-	24	31	
Gate plateau voltage	$V_{plateau}$		-	3.2	-	V

### Reverse Diode

Diode continuous forward current <sup>2)</sup>	$I_S$	$T_C=25^\circ C$	-	-	50	A
Diode pulse current <sup>2)</sup>	$I_{S,pulse}$		-	-	200	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_F=50A,$ $T_j=25^\circ C$	0.6	0.95	1.3	V
Reverse recovery time <sup>2)</sup>	$t_{rr}$	$V_R=30V, I_F=I_S,$ $di_F/dt=100A/\mu s$	-	17	-	ns
Reverse recovery charge <sup>2)</sup>	$Q_{rr}$		-	14	-	nC

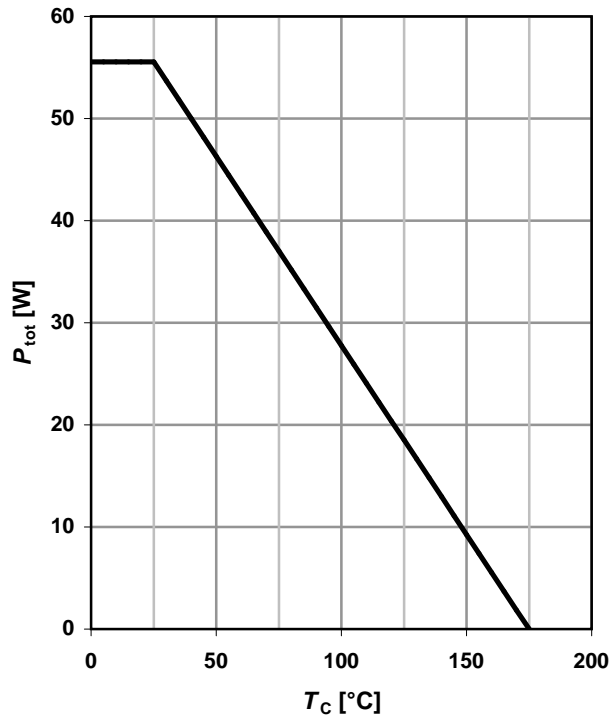
<sup>1)</sup> Current is limited by bondwire; with an  $R_{thJC} = 2.7K/W$  the chip is able to carry 77A at 25°C.

<sup>2)</sup> Defined by design. Not subject to production test.

<sup>3)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 μm thick) copper area for drain connection. PCB is vertical in still air.

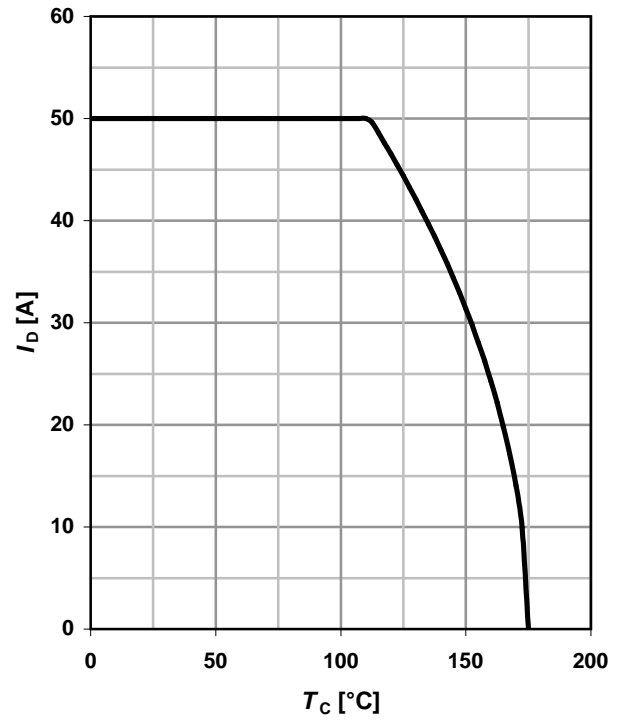
**1 Power dissipation**

$P_{tot} = f(T_C); V_{GS} \geq 6\text{ V}$



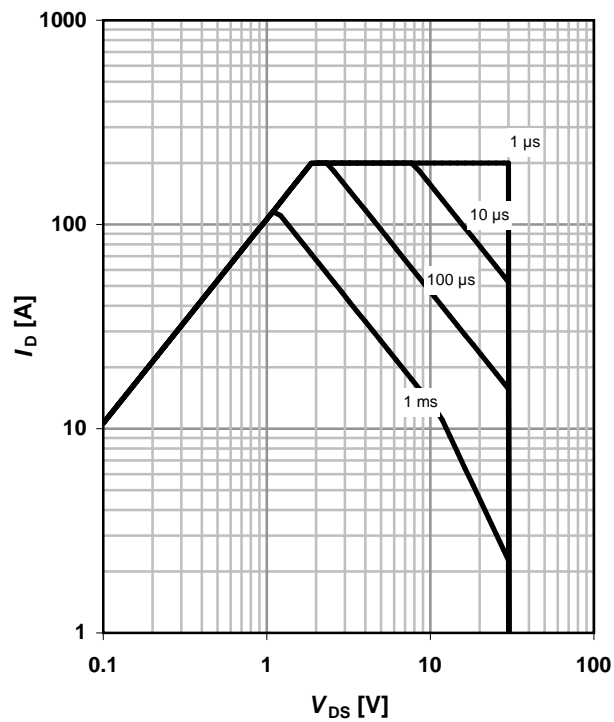
**2 Drain current**

$I_D = f(T_C); V_{GS} \geq 6\text{ V}$



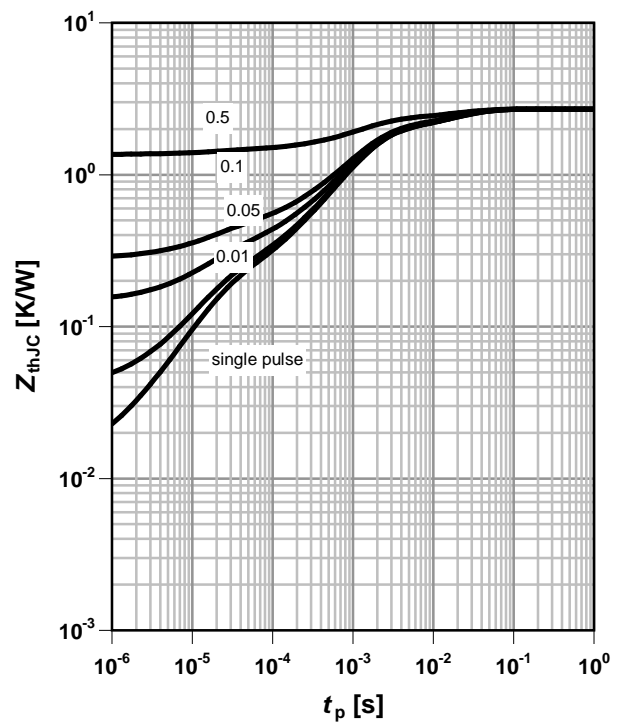
$I_D = f(V_{DS}); T_C = 25\text{ °C}; D = 0$

parameter:  $t_p$



$Z_{thJC} = f(t_p)$

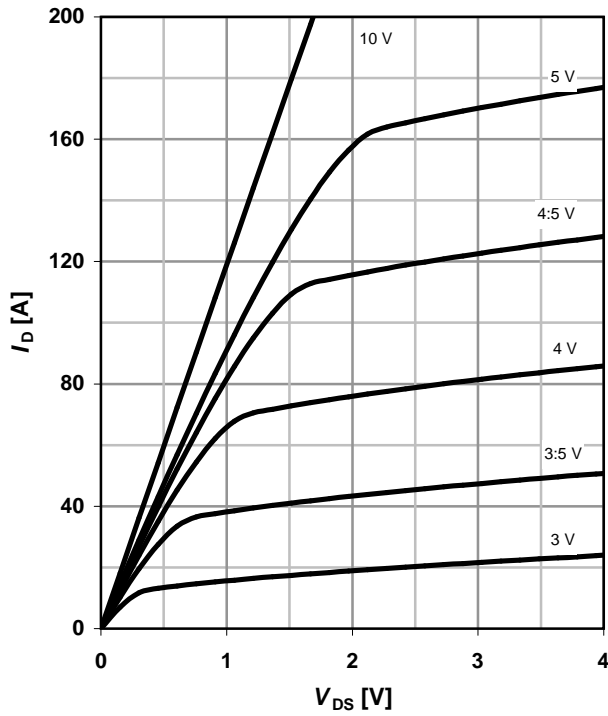
parameter:  $D = t_p/T$



**5 Typ. output characteristics**

$I_D = f(V_{DS}); T_j = 25\text{ °C}$

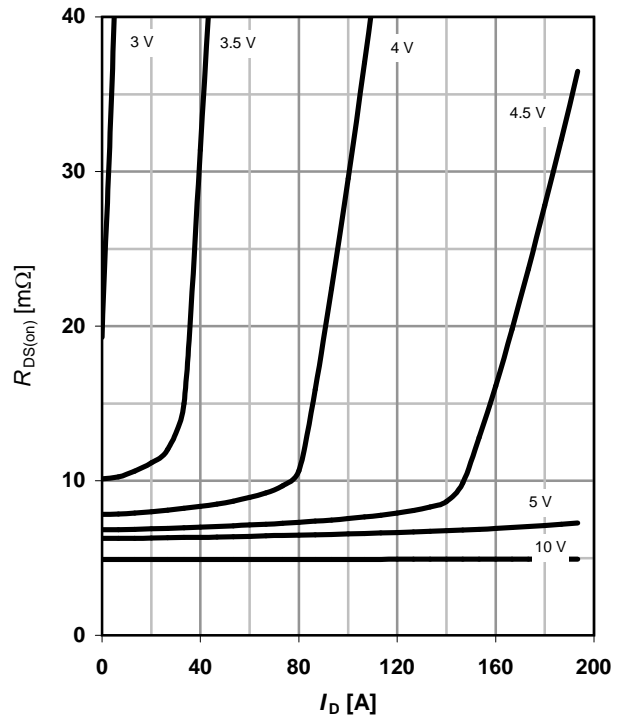
parameter:  $V_{GS}$



**6 Typ. drain-source on-state resistance**

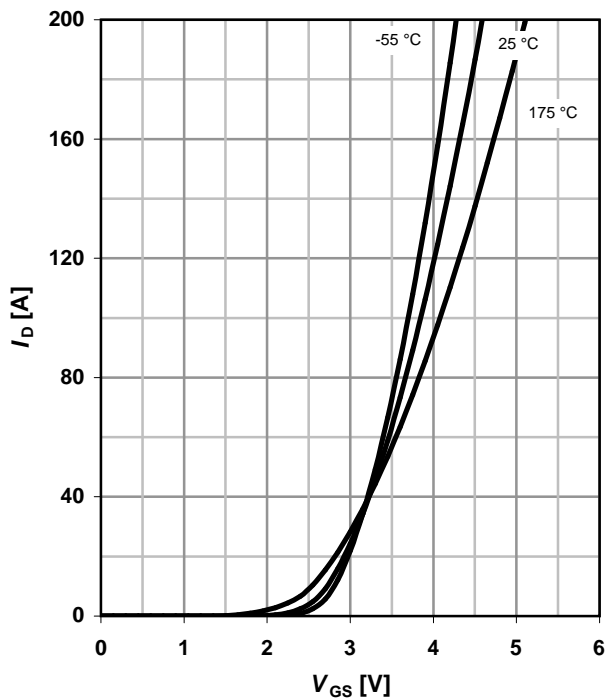
$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}$

parameter:  $V_{GS}$

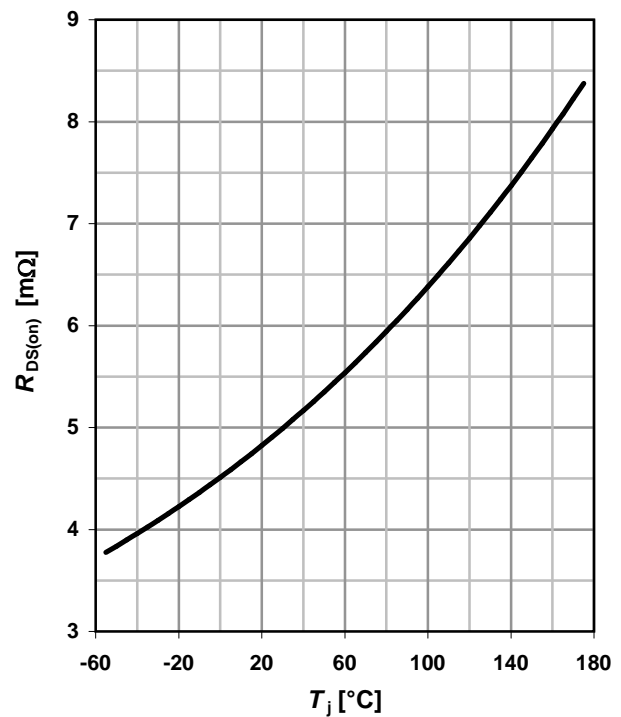


$I_D = f(V_{GS}); V_{DS} = 6\text{ V}$

parameter:  $T_j$



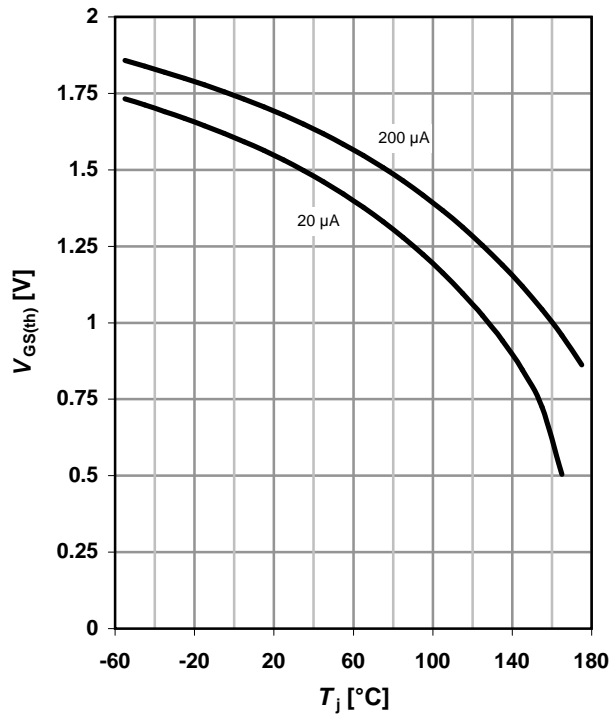
$R_{DS(on)} = f(T_j); I_D = 50\text{ A}; V_{GS} = 10\text{ V}$



**9 Typ. gate threshold voltage**

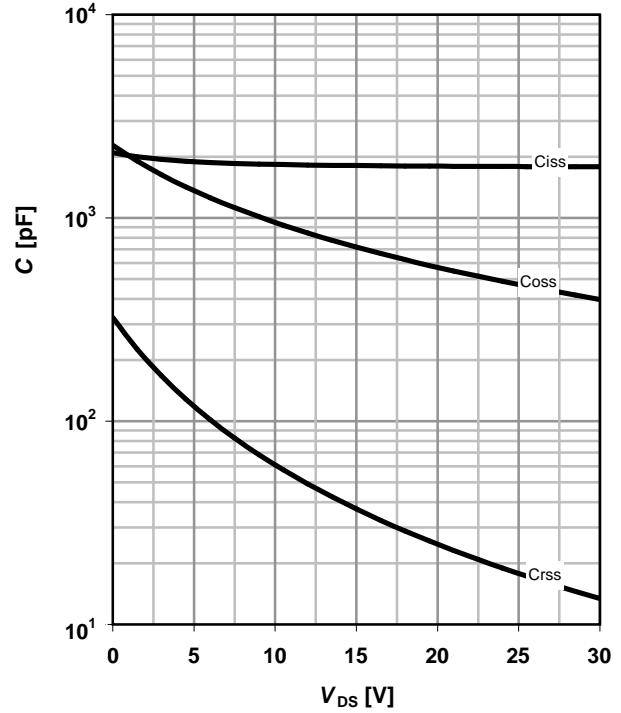
$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$

parameter:  $I_D$



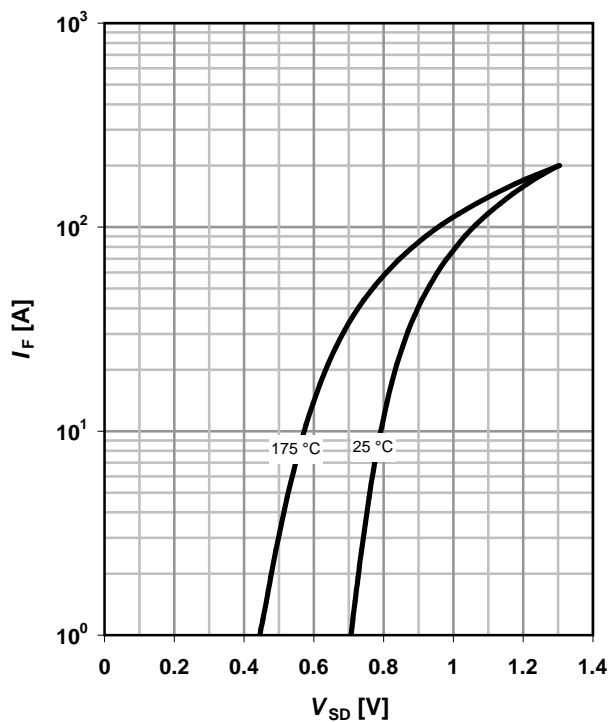
**10 Typ. capacitances**

$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$



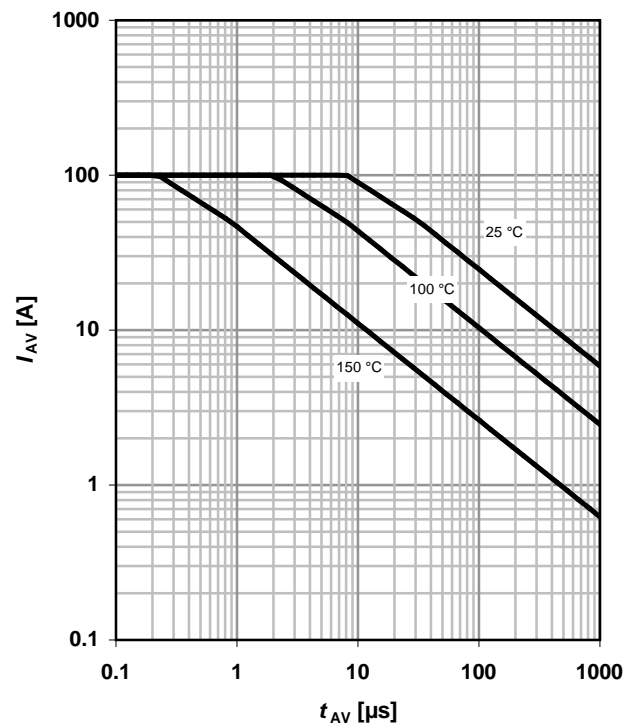
$I_F = f(V_{SD})$

parameter:  $T_j$



$I_{AS} = f(t_{AV})$

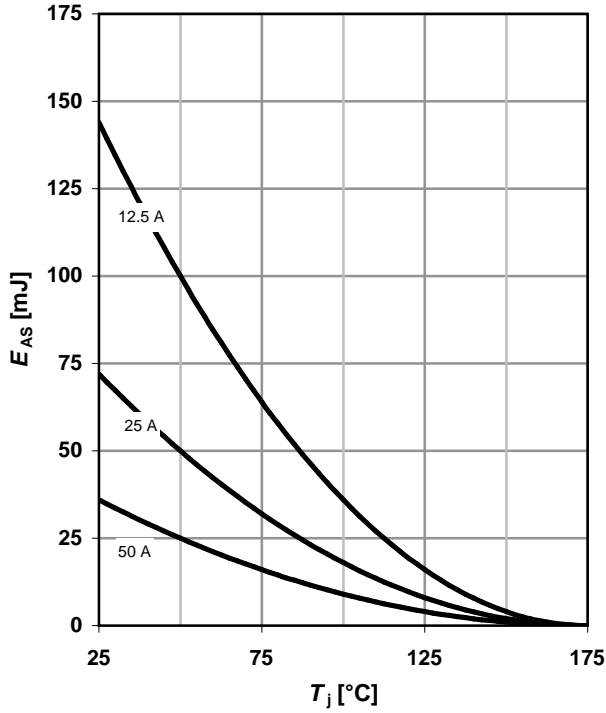
parameter:  $T_{j(start)}$



**13 Avalanche energy**

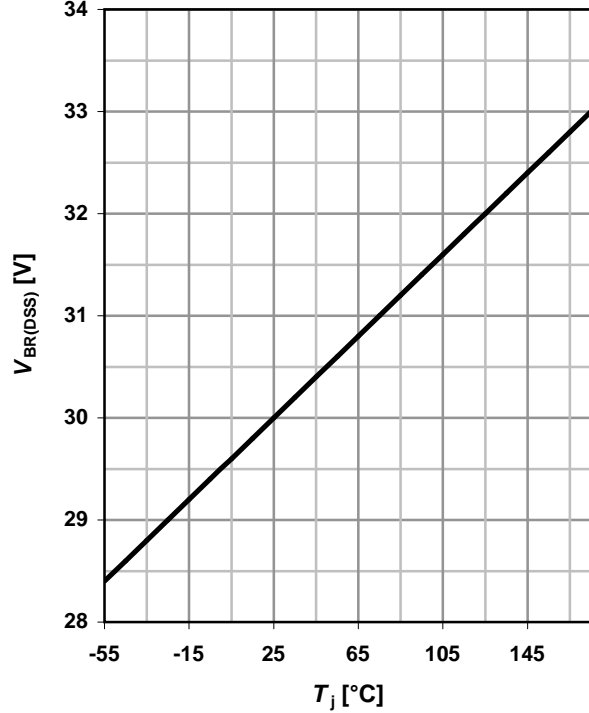
$$E_{AS} = f(T_j)$$

parameter:  $I_D$



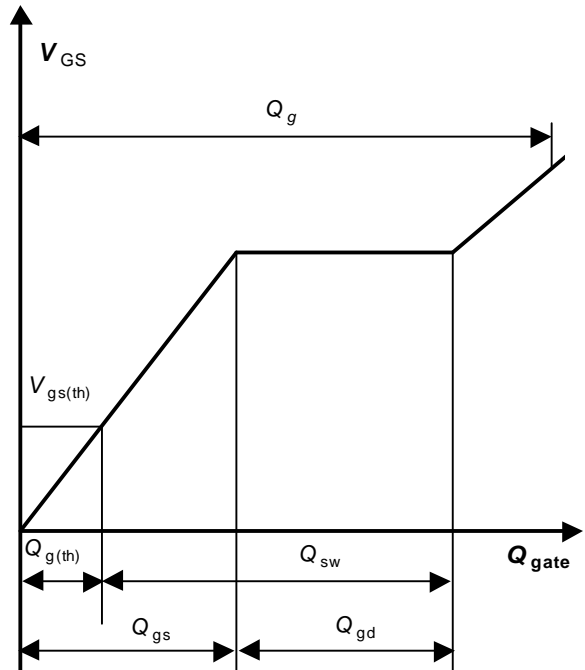
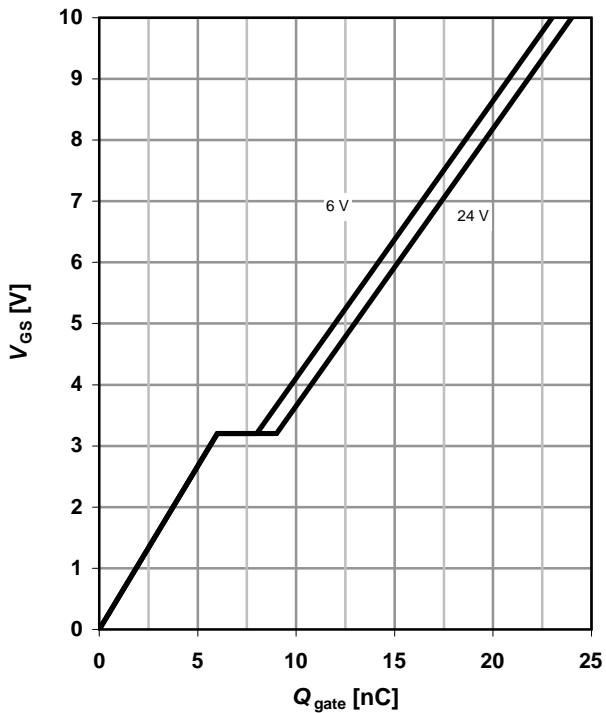
**14 Drain-source breakdown voltage**

$$V_{BR(DSS)} = f(T_j); I_D = 1 \text{ mA}$$



$$V_{GS} = f(Q_{gate}); I_D = 50 \text{ A pulsed}$$

parameter:  $V_{DD}$



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## Revision History

Version	Date	Changes
Revision 1.1	05.10.2010	Correction of pinout diagram



**Стандарт  
Электрон  
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**Наши контакты:**

**Телефон:** +7 812 627 14 35

**Электронная почта:** [sales@st-electron.ru](mailto:sales@st-electron.ru)

**Адрес:** 198099, Санкт-Петербург,  
Промышленная ул, дом № 19, литера Н,  
помещение 100-Н Офис 331